Shenzhen TCD Testi	ng Technology Co.,LTD	Report No.: TCD20160302103013E-1
Ka.	(xo)	(CO
	EMC TEST REPORT	
(CO)	For Mobile Power Bank	
		KCO
Model No	: Lighthouse 5	400
Prepared for	:	
Address		(CO
Prepared by Address Tel Fax Web	 Shenzhen TCD Testing Technology 6F,Liansheng Building,Gushu 1Rd,Z Shenzhen, Guangdong, China (+86)755-29760321 (+86)755-29781725 www.tcd-cert.com 	
Date of receipt of test sample Number of tested samples Serial number Date of Test Date of Report	 Feb 26, 2016 1 Prototype Feb 26, 2016 - Mar 02, 2016 Mar 02, 2016 	
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Shenzhen TCD Testing T		Report No.: TCD201603021030
	EMC TEST REPORT	
Information technology equi	EN 55022: 2010 pment-Radio disturbance characteri EN 55024: 2010	stics-Limits of measurement
Information technology equipment	nt-Immunity characteristics-Limits a measurement	and methods of measurement of
Report Reference No ⁻	··· : TCD20160302103013E- 1	
Date Of Issue	: Mar 02, 2016	
	: Shenzhen TCD Testing Techn : 6F,Liansheng Building,Gsuhu 1 District,Shenzhen,Guangdong,G	lst Road, Xixiang Street, Baoan
Testing Location/ Procedure	Full application of Harmonised Partial application of Harmonis	ed standards
(<u>x</u> G ^V)	Other standard testing method	
Applicant's Name		
Test Specification Standard	: EN 55022: 2010+AC:2011 EN 55024: 2010 EN 61000-3-2: 2014 EN 61000-3-3: 2013	(10)
Test Report Form No.	: TCD20140719	
TRF Originator Master TRF	Shenzhen TCD Testing TechnolDated 2011-03	ogy Co.,LTD
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Test Item Description	: Mobile Power Bank	
Trade Mark	ង ព្រែ ភិត្តិស	
Model/ Type Reference	: Lighthouse 5	,
Ratings	: Input:5V/1A Output:5V/2.1A	12000mAh
Result	: Positive	
Compiled by:	Supervised by:	Approved by:
		CONTESTING TECHNO
Jack Li	Bitalin	13HS 011.0
Jack Li Jake Li/File administrators	Rite Liu/ Technique principal	Levis Li/ Manager

	g Technology Co.,LTD		Report No.: TCD20160.	30210.
У	EMC TEST RE	PORT		
				(
Test Report No. : TC	D20160302103013E- 1		Mar 02, 2016	
			Date of issue	
Type / Model	: Lighthouse 5			
EUT	: Mobile Power Bank			(
Applicant				4
Telephone Fax			(20)	
Manufacturer				
Telephone Fax	: /	(100)		
Factory				
Telephone Fax			(CO)	
Test Result according to t	he standards on page 6: Po	ositive		
The test report merely corr It is not permitted to copy laboratory.	esponds to the test sample. v extracts of these test result	without the v	written permission of	the
)	(CO)		(10)	

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	7.3. Severity Levels and Performance Criterion			
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8.1.Photo of Radiat	ted Measurement			24
8.3.Photo of Magne 9. EXTERNAL AND	ostatic Discharge Test etic Field Immunity Test INTERNAL PHOTOS OF TH	E EUT		25 26
			(CO)	
KCD)	(CO)		(10)
(0)	(CO)		(0)	
KCO		(CO)		(10)
KCD			(0)	
400)			
<u>(</u> CO)	(CO)			
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Description of Test Item

Conducted disturbance

at mains terminals

Report No.: TCD20160302103013E-1

Limits

Class B

Results

PASS

1. SUMMARY OF STANDARDS AND RESULTS

1.1. Description of Standards and Results

The EUT have been tested according to the applicable standards as referenced below.

EMISSION (EN 55022: 2010)

Standard

EN 55022: 2010





Conducted disturbance at telecommunication port	EN 55022: 2010	Class B	PASS
Radiated disturbance	EN 55022: 2010	Class B	PASS
Harmonic current emissions	EN 61000-3-2: 2014	Class A	PASS
Voltage fluctuations & flicker	EN 61000-3-3: 2013		PASS
	IMMUNITY(EN 55024: 2010)		
Description of Test Item	Basic Standard	Performance Criteria	Results
Electrostatic discharge (ESD)	EN 61000-4-2: 2009	В	PASS
Radio-frequency, Continuous radiated disturbance	EN 61000-4-3: 2006+A1: 2008+A2: 2010	А	PASS
Electrical fast transient (EFT)	EN 61000-4-4: 2012	В	N/A
Surge (Input a.c. power ports)	EN 61000-4-5: 2014	В	N/A
Surge (Telecommunication ports)	EN 01000-4-5. 2014	В	N/A
Radio-frequency, Continuous conducted disturbance	EN 61000-4-6: 2014	А	N/A
Power frequency magnetic field	EN 61000-4-8: 2010	А	PASS
Voltage dips, >95% reduction		В	N/A
Voltage dips, 30% reduction	EN 61000-4-11: 2004	В	N/A
Voltage interruptions		С	N/A

N/A is an abbreviation for Not Applicable.

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1.2.Description of Performance Criteria

General Performance Criteria

Examples of functions defined by the manufacturer to be evaluated during testing include, but are not limited to, the following:

- essential operational modes and states;

— tests of all peripheral access (hard disks, floppy disks, printers, keyboard, mouse, etc.);

- quality of software execution;
- quality of data display and transmission;
- quality of speech transmission.

1.2.1.Performance criterion A

The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacture when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be deriver from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

1.2.2.Performance criterion B

After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacture, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.

During the test, degradation of performance is allowed. However, no change of operation state or stored data is allowed to persist after the test.

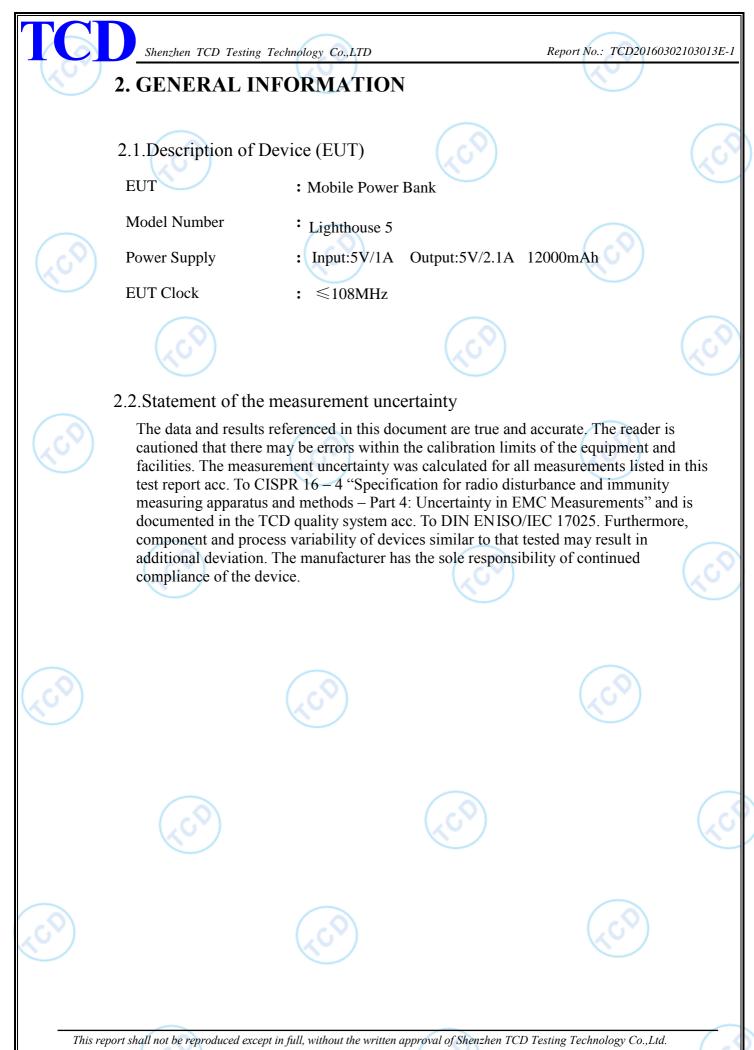
If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be deriver from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

1.2.3.Performance criterion C

Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacture's instructions.

Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be loss.

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2.4.Measurement Uncertainty

Test Item	Frequency Range	Expanded uncertainty (Ulab)	Expanded uncertainty (Ucispr)	3
	(9kHz to 150kHz)	2.63 dB	4.0 dB	
Conducted Emission	(150kHz to 30MHz)	2.35 dB	3.6 dB	
Power disturbance	(30MHz to 300MHz)	2.90dB	4.5 dB	
Electromagnetic Radiated Emission (3-loop)	(9kHz to 30MHz)	3.60 dB	N/A	
Radiated Emission	(9kHz to 30MHz)	3.68 dB	N/A	
Radiated Emission	(30MHz to 1000MHz)	3.48 dB	5.2 dB	0
Radiated Emission	(above 1000MHz)	3.90 dB	N/A	υ,
Mains Harmonic	Voltage	0.510%	N/A	
Voltage Fluctuations & Flicker	Voltage	0.510%	N/A	
	\frown	•		

(1) Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the apparatus.

(2) The reported expanded uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor of k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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3. MEASURING DEVICES AND TEST EQUIPMENT

3.1.Conducted Disturbance

[Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
ſ	1	EMI Test Receiver	ROHDE & SCHWARZ	ESCI	101142	2015/06/18
	2	10dB Attenuator	SCHWARZBECK	OSPAM236	9729	2015/06/18
	3	Artificial Mains	ROHDE & SCHWARZ	ENV216	101288	2015/06/18
	4	EMI Test Software	AUDIX	E3	N/A	2015/06/18

3.2.Disturbance Power

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	EMI Test Receiver	ROHDE & SCHWARZ	ESCI	101142	2015/06/18
2	Absorbing clamp	ROHDE & SCHWARZ	MDS 21	4033	2015/08/30
3	EMI Test Software	AUDIX	E3	N/A	2015/06/18

3.3.Radiated Electromagnetic Disturbance

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	EMI Test Receiver	ROHDE & SCHWARZ	ESCI	1011423	2015/06/18
2	Triple-loop Antenna	EVERFINE	LLA-2	11050003	2015/06/18
3	EMI Test Receiver	ROHDE & SCHWARZ	ESPI	101840	2015/06/18
4	EMI Test Software	AUDIX	E3	N/A	2015/06/18

3.4.Radiated Disturbance (Electric Field)

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	3m Semi Anechoic Chamber	SIDT FRANKONIA	SAC-3M	03CH03-HY	2015/02/04
2	EMI Test Receiver	ROHDE & SCHWARZ	ESPI	101840	2015/06/18
3	Log per Antenna	SCHWARZBECK	VULB9163	9163-470	2015/06/18
4	EMI Test Software	AUDIX	E3	N/A	2015/06/18
5	Positioning Controller	MF	MF-7082	/	2015/06/18

3.5.Harmonic Current

		C Y			
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	Power Analyzer Test System	Voltech	PM6000	20000670053	2015/06/18

3.6. Voltage fluctuation and Flicker

Item	Test Equipment	Manufacturer		Model No.	Serial No.	Last Cal.
1	Power Analyzer Test System	Voltech	6	PM6000	20000670053	2015/06/18

3.7.Electrostatic Discharge

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	ESD Simulator	KIKUSUI	KC001311	KES4021	2015/09/02
		∠G [∨])		120	

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3.8.RF Field Strength Susceptibility

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	SIGNAL GENERATOR	HP	8648A	625U00573	2015/06/18
2	Amplifier	AR	500A100	17034	2015/06/18
3	Amplifier	AR	100W/1000M1	17028	2015/06/18
4	Isotropic Field Monitor AR		FM2000	16829	2015/06/18
5	Isotropic Field Probe	AR	FP2000	16755	2015/06/18
6	Bi-conic Antenna	EMCO	3108	9507-2534	2015/06/18
7	By-log-periodic Antenna	AR	AT1080	16812	2015/06/18
8	EMS Test Software	ROHDE & SCHWARZ	ESK1	N/A	2015/06/18

3.9.Electrical Fast Transient/Burst

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	Electrical fast transient(EFT)generator	3CTEST	EFT-4021	EC0461044	2015/01/20
2	Coupling Clamp	3CTEST	EFTC	EC0441098	2015/06/18

3.10.Surge

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	Surge test system	3CTEST	SG5006G	EC5581070	2015/06/18
2	Coupling/decoupling network	3CTEST	SGN-5010G	CS5591033	2015/06/18

3.11.Conducted Susceptibility

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	Simulator	EMTEST	CWS500C	0900-12	2015/06/18
2	CDN	EMTEST	CDN-M2	5100100100	2015/06/18
3	CDN	EMTEST	CDN-M3	0900-11	2015/06/18
4	CDN	EMTEST	CDN-M	0900-12	2015/06/18
5	Attenuator	EMTEST	ATT6	0010222A	2015/06/18
6	Infuse tongs	EMTEST	EM-Clamp	0513A031201	2015/06/18

3.12. Power Frequency Magnetic Field Susceptibility

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	Power frequency mag-field generator System	EVERFINE	EMS61000-8K	906003	2015/06/18

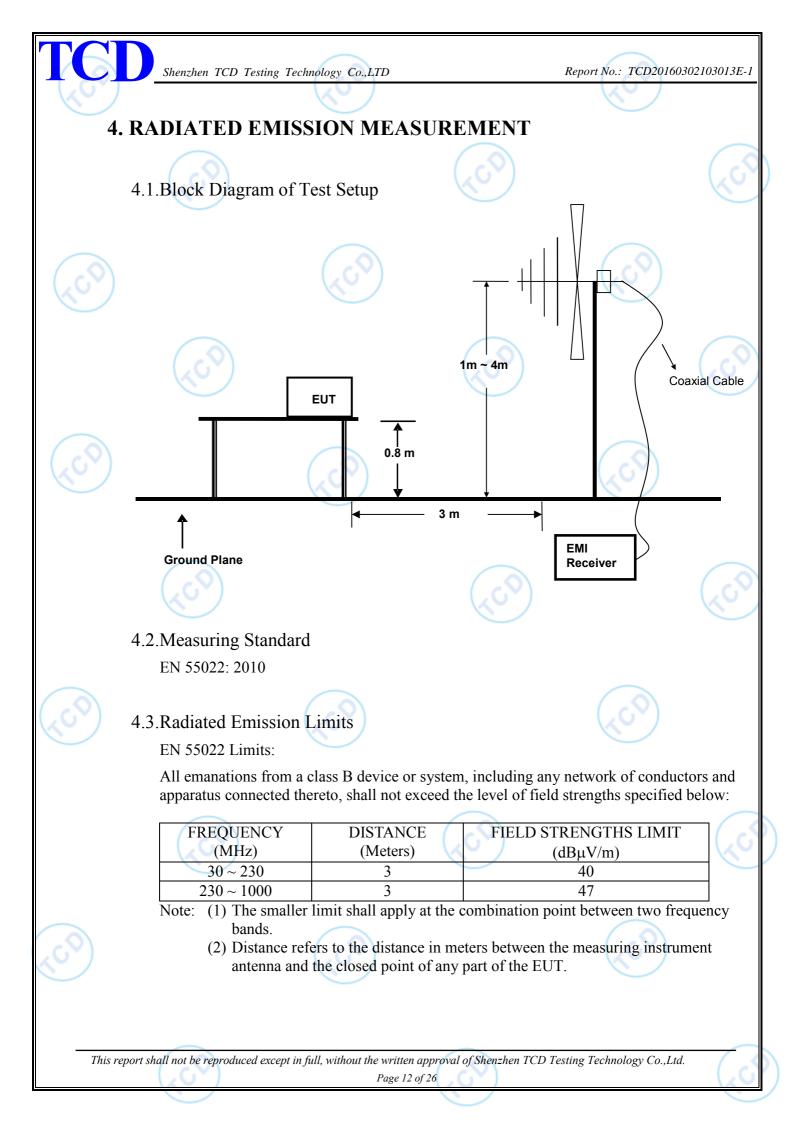
3.13.Voltage Dips

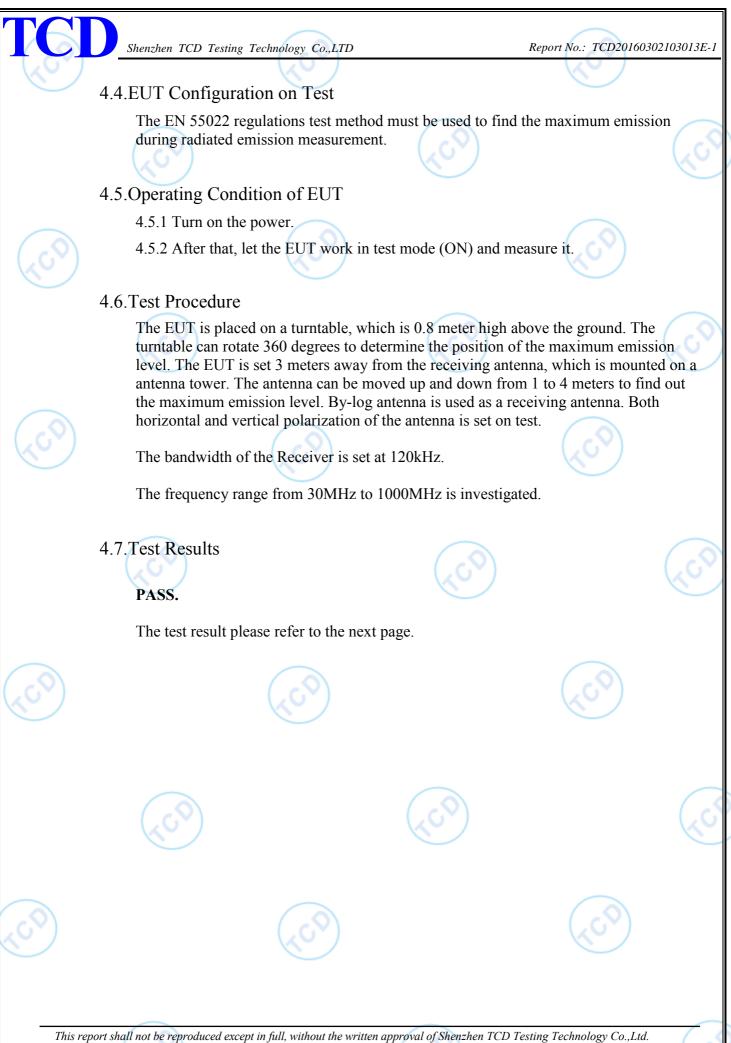
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	Voltage dips and up generator	3CTEST	VDG-1105G	EC0171014	2015/06/18

3.14. Voltage Short Interruptions

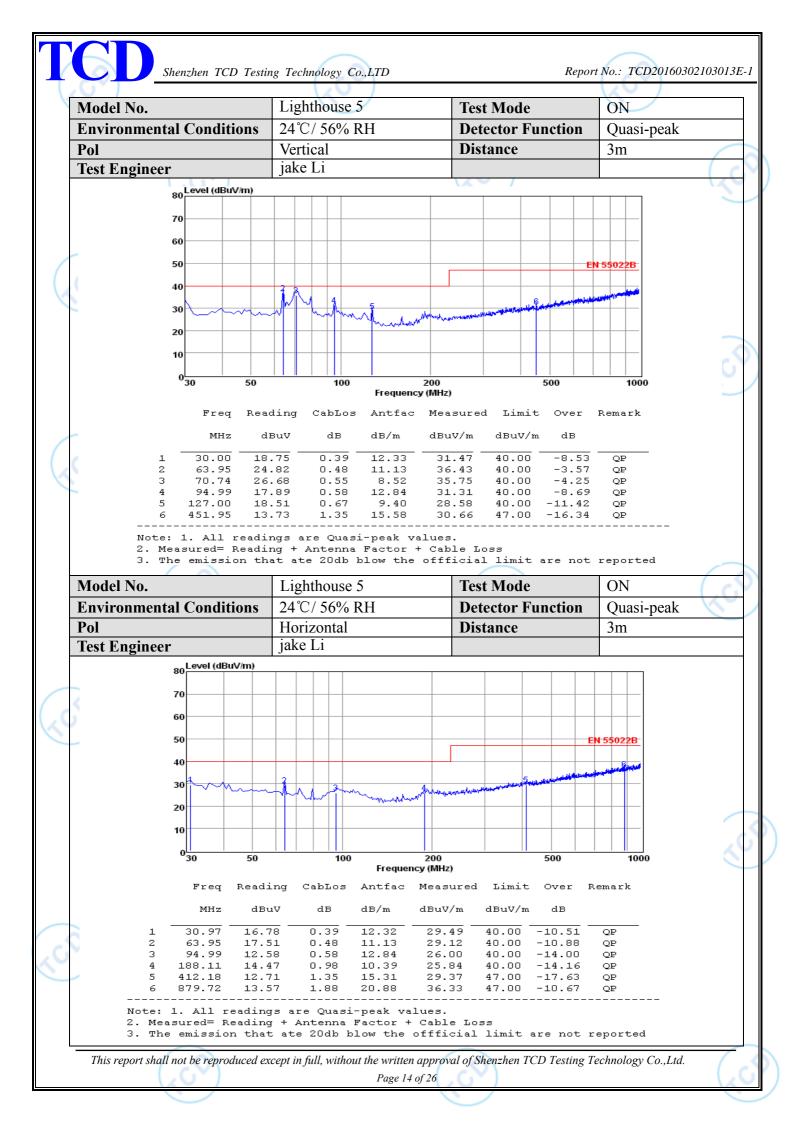
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	Voltage dips and up generator	3CTEST	VDG-1105G	EC0171014	2015/06/18

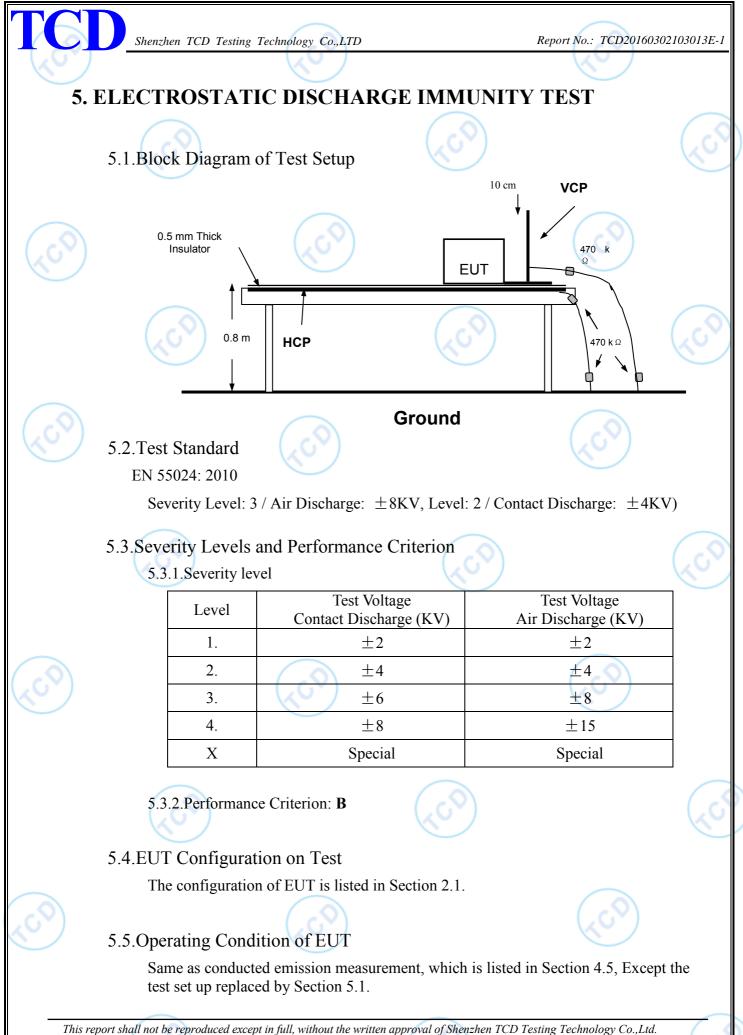
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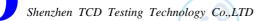
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5.6.Test Procedure

5.6.1.Air Discharge

This test is done on a non-conductive surface. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed

5.6.2.Contact Discharge

All the procedure shall be same as Section 5.6.1. Except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

5.6.3.Indirect Discharge For Horizontal Coupling Plane

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the center point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

5.6.4.Indirect Discharge For Vertical Coupling Plane

At least 10 single discharge (in the most sensitive polarity) shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.

5.7.Test Results

PASS.

Please refer to the following pages

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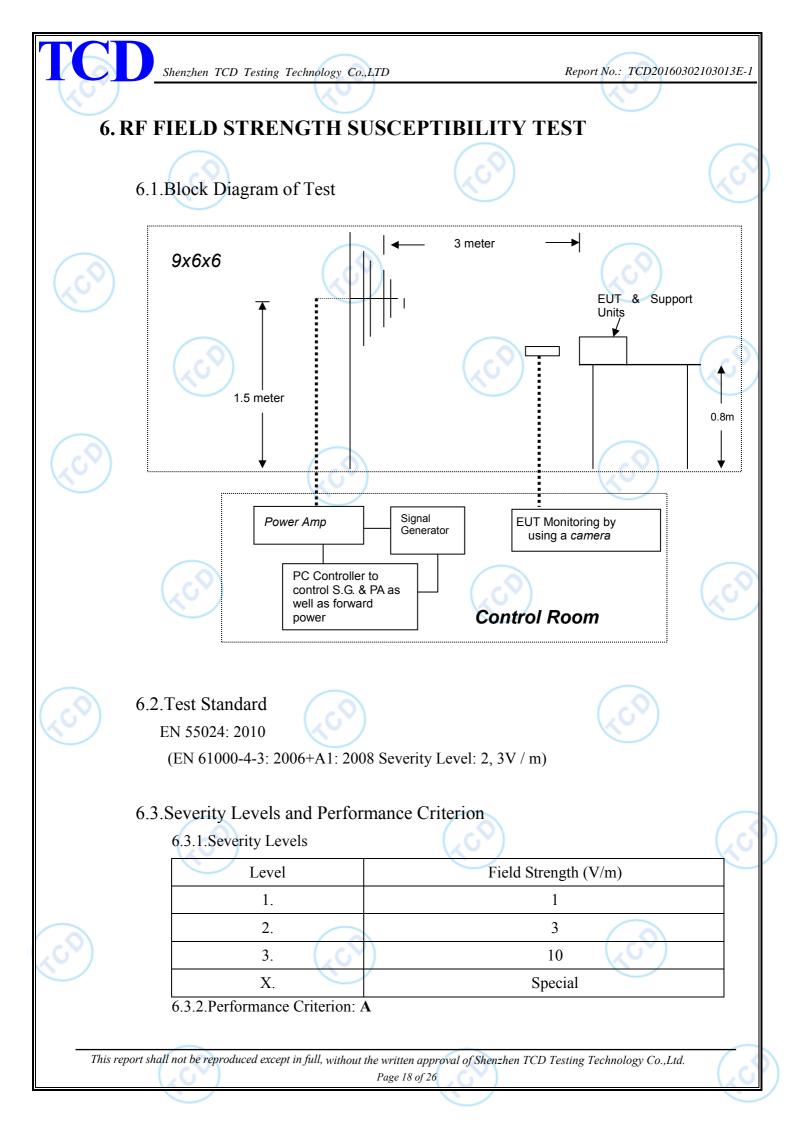
Report No.: TCD20160302103013E-1

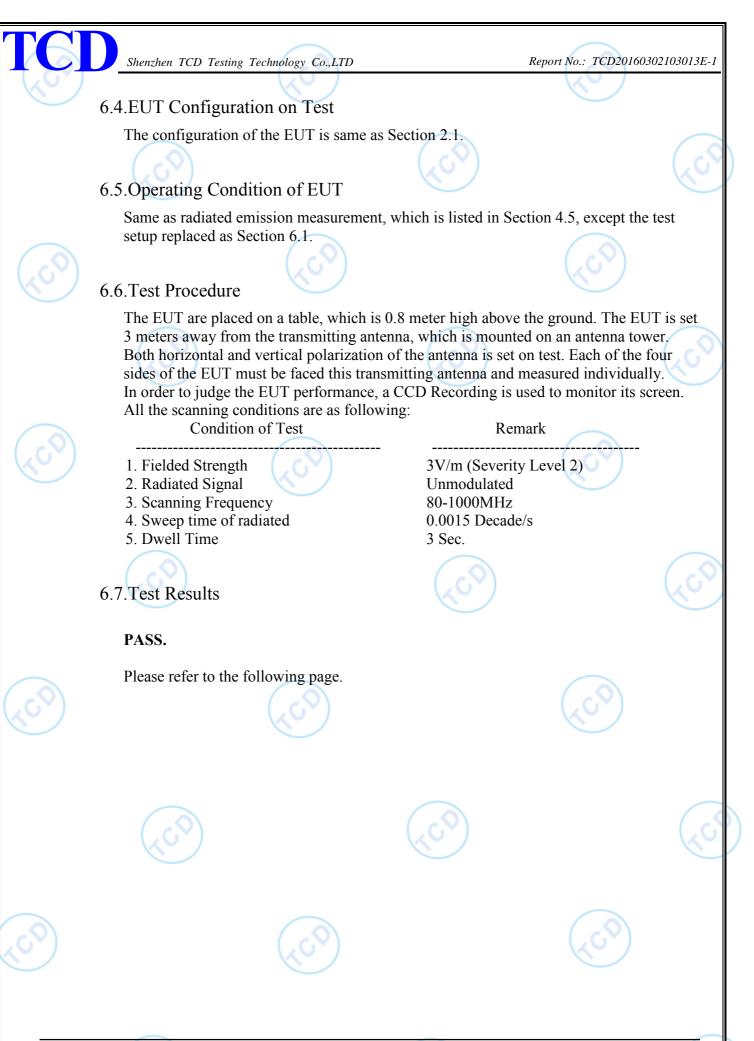
Electrostatic Discharger Test Results

Standard	d □ IEC 61000-4-2 ☑ EN 61000-4-2					
Applicant		\smile				
EUT	Mobile Power Bank	Temperature24°C				
M/N	Lighthouse 5	Humidity 53%	(\mathbf{Q})			
Criterion	В	Pressure 1021	mbar			
Test Mode	ON	Test Engineer jake	Li			

		Test Level		scharge	esults	
Fest Points	± 2kV	$\pm 4 kV$	$\pm 8 kV$	Passed	Fail	Performance Criterion
Front		\boxtimes		\square		
Back		\boxtimes	\square			
Left		\boxtimes				
Right	\square	$\overline{\boxtimes}$				$\square A \square B$
Тор	\square	\boxtimes				$\square A \square B$
Bottom	\square	\square				$\square A \square B$
			Contact	Discharge		
	Tes	t Levels			Results	1
Test Points	± 2 kV	r :	±4 kV	Passed	Fail	Performance Criterion
Front			\boxtimes	\square		
Back	\square		\boxtimes	\square		
Left			\boxtimes	\square		
Right			\boxtimes	\square		
Тор			\boxtimes	\square		
Bottom			\boxtimes	\square		
	•	Discha	arge To H	orizontal C	Coupling P	lane
	Test	Levels		Results		
Side of EUT	± 2 kV	:	± 4 kV	Passed	Fail	Performance Criterion
Front	\square		\boxtimes	\boxtimes		$\square A \square B$
Back	\square		\boxtimes	\square		$\square A \square B$
Left			\boxtimes	\square		$\Box A \boxtimes B$
Right			\boxtimes	\square		$\Box A \boxtimes B$
		Discha	arge To V	ertical Cou	pling Plar	ie
	Те	st Levels			Resul	
Side of EUT	± 2 kV	' :	± 4 kV	Passed	Fail	Performance Criterion
Front			\boxtimes			$\Box A \boxtimes B$
Back	\boxtimes		\boxtimes	\square		$\Box A \boxtimes B$
Left			\boxtimes	\square		$\Box A \boxtimes B$
Right	\square		\bowtie	\square		

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RF Field Strength Susceptibility Test Results

Standard	□ IEC 61000-4-3 ☑ EN 61000-4-3	IEC 61000-4-3 ☑ EN 61000-4-3						
Applicant								
EUT	Mobile Power Bank	Temperature	24°C					
M/N	Lighouse 5	Humidity	53%					
Field Strength	3 V/m	Criterion	A					
Test Mode	ON	Test Engineer	jake Li					
Frequency Range	80 MHz to 1000 MHz							
Modulation	□None □ Pulse ☑AM	1KHz 80%	(_ <c^< th=""></c^<>					
Steps	1%							

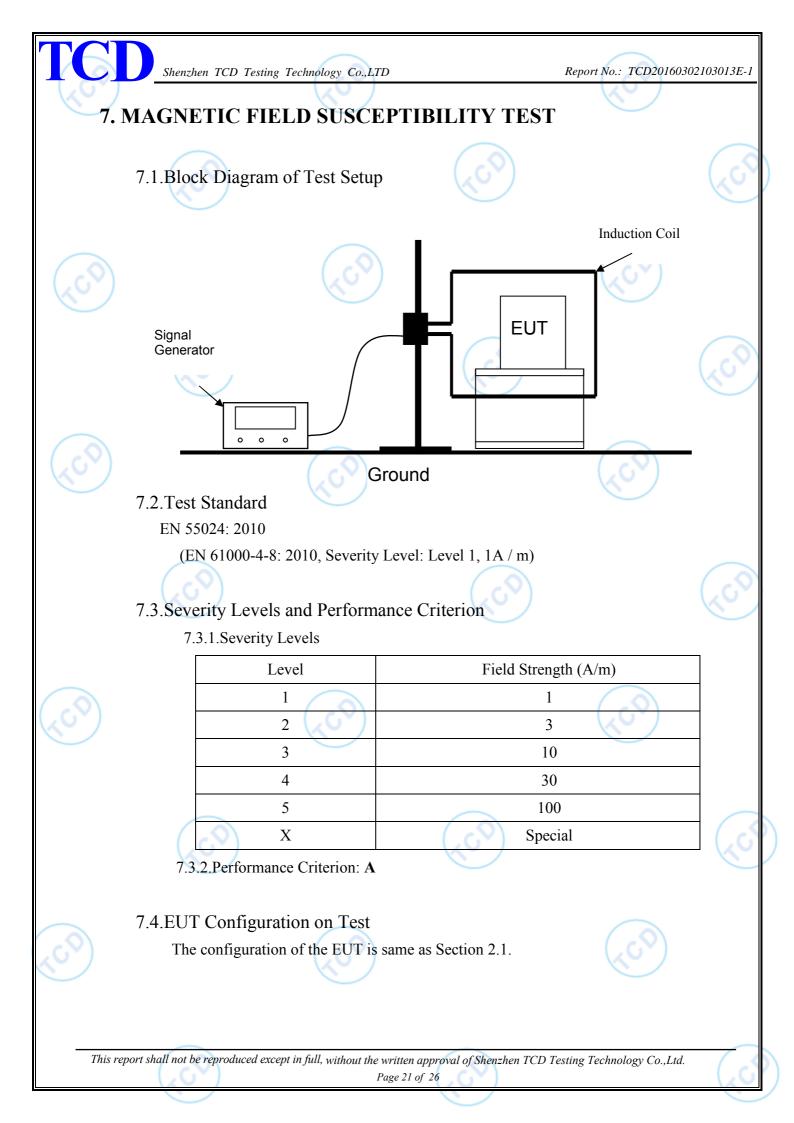
	Horizontal	Vertical		
Front	PASS	PASS		
Right	PASS	PASS		
Rear	PASS	PASS		
Left	PASS	PASS		

Test Equipment:

Note:

- 1. Signal Generator: 2031 (MARCONI)
- 2. Power Amplifier: 500A100 & 100W/1000M1 (A&R)
- 3. Power Antenna: 3108 (EMCO) & AT1080 (A&R)
- 4. Field Monitor: FM2000 (A&R)

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(°)	Shenzhen TCD Testing Technology Co		Report No.: TCD201603021030)15L
	7.5.Test Procedure			
	The EUT is placed in the mid (high) table, this small table is Both horizontal and vertical p side of the EUT is affected by change the position of the EU	s also placed on a larger tab polarization of the induction the magnetic field. Also ca	le, 0.8 m above the ground. coil is set on test, so that eac	
<u> </u>	7.6.Test Results PASS.		(CO)	
	Please refer to the following p	bage.		5
	400)	400	
	400			5
	(CO)	400	
			(<
,0				

Report No.: TCD20160302103013E-1

Standard	/lagnetic Fie □ IEC 61000-4-8	☑ EN 61000-4-	C s Y J		
Applicant	ľ				
EUT	Mobile Power Banl	ĸ	Temperature	24℃	
M/N	Lighthouse 5	5	Humidity	53%	
Test Mode	ON	C	Criterion	А	
Test Engineer	jake Li	jake Li			
Test Level (A/M)	Testing Duration	Coil Orientation	Criterion	Result	
1	5 mins	Х	А	PASS	
	5 mins	Y	А	PASS	
1	5 mins	Z	А	PASS	
		40	,0		
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